Search Notes

App	olica	tion/Co	ontrol	No.
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Applicant(s)/Patent under Reexamination

TAKAHAMA ET AL.

10/826,271

Examiner

Art Unit

Luke D. Ratcliffe

3662

SEARCHED					
Class	Subclass	Date	Examiner		
356	28.5	1/16/2007	LDR		
			:		

INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	
	RFERENCE RCH	1/16/2007	LDR	

SEARCH NO (INCLUDING SEARCH)
	DATE	EXMR
356/28.5,27,28,4.09-4.1 701/93-98,116-119,301,302,28	1/16/2007	LDR
EAST text search	1/16/2007	LDR
IEEE search	1/16/2007	LDR
ECLA search	1/16/2007	LDR
SPIE search	1/16/2007	LDR